



YOUSHANG SEMICONDUCTOR

设计研发新型功率器件

各类小信号开关

中低压及高压大电流等场效应管

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企业微信二维码



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Product Summary

$V_{(BR)DSS}$	Max $R_{DS(ON)}$	Max I_D $T_A = +25^\circ\text{C}$ (Note 6)
-30V	70m Ω @ $V_{GS} = -10\text{V}$	-4A

Features and Benefits

- Low On-Resistance
- Fast Switching Speed
- Low Threshold
- Low Gate Drive

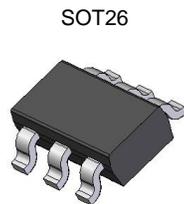
Description and Applications

This new generation of TRENCH MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.

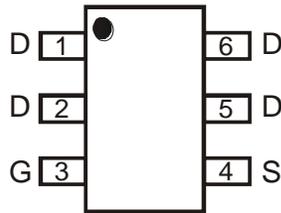
- DC - DC Converters
- Power Management Functions
- Disconnect Switches
- Motor Control

Mechanical Data

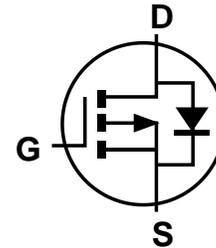
- Case: SOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish – Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 ^{Ⓔ3}
- Weight: 0.016 grams (Approximate)



Top View



Pin-Out (Top View)



Equivalent Circuit

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Drain-Source Voltage		V _{DSS}	-30	V	
Gate-Source Voltage		V _{GS}	±20	V	
Continuous Drain Current	V _{GS} = -10V	I _D	T _A = +25°C (Note 6)	-4.0	A
			T _A = +70°C (Note 6)	-3.2	
			T _A = +25°C (Note 5)	-3.2	
Pulsed Drain Current (Note 7)		I _{DM}	-14.4	A	
Continuous Source Current (Body Diode) (Note 6)		I _S	-2.5	A	
Pulsed Source Current (Body Diode) (Note 7)		I _{SM}	-14.4	A	

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

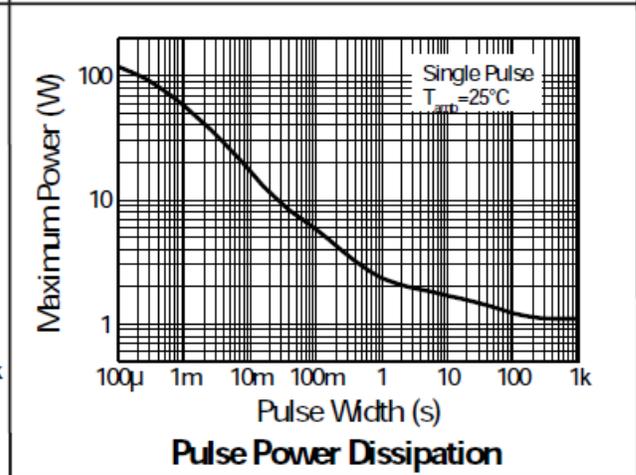
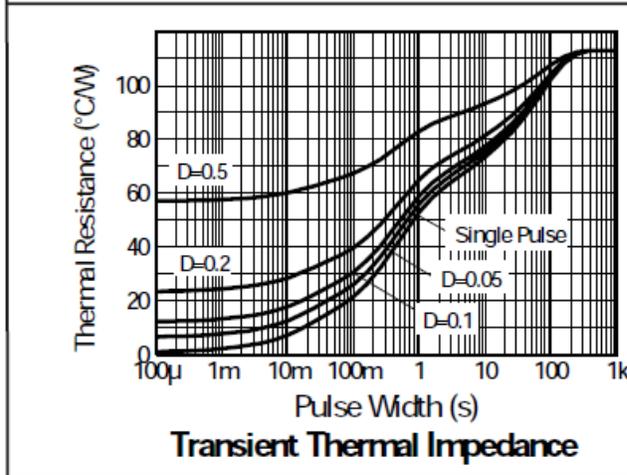
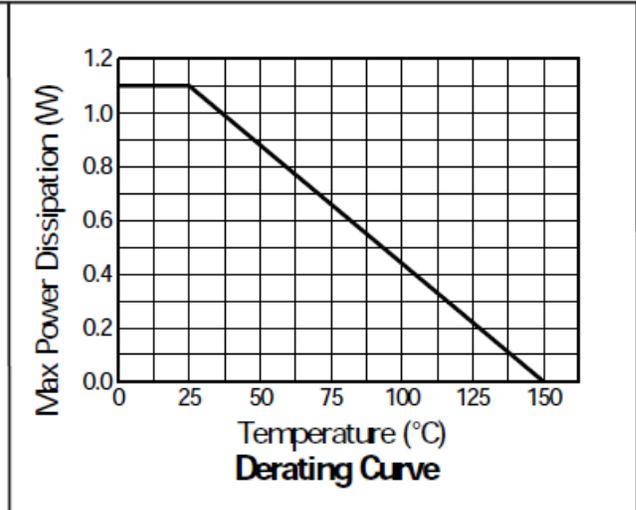
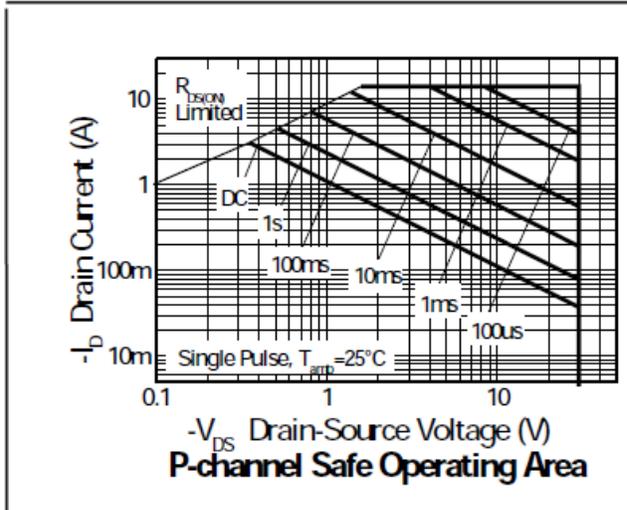
Characteristic	Symbol	Value	Unit
Power Dissipation at T _A = +25°C (Note 5)	P _D	1.1	W
Linear derating factor		8.8	mW/°C
Power Dissipation at T _A = +25°C (Note 6)	P _D	1.7	W
Linear Derating Factor		13.6	mW/°C
Junction to Ambient (Note 5)	R _{θJA}	113	°C/W
Junction to Ambient (Note 6)	R _{θJA}	73	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

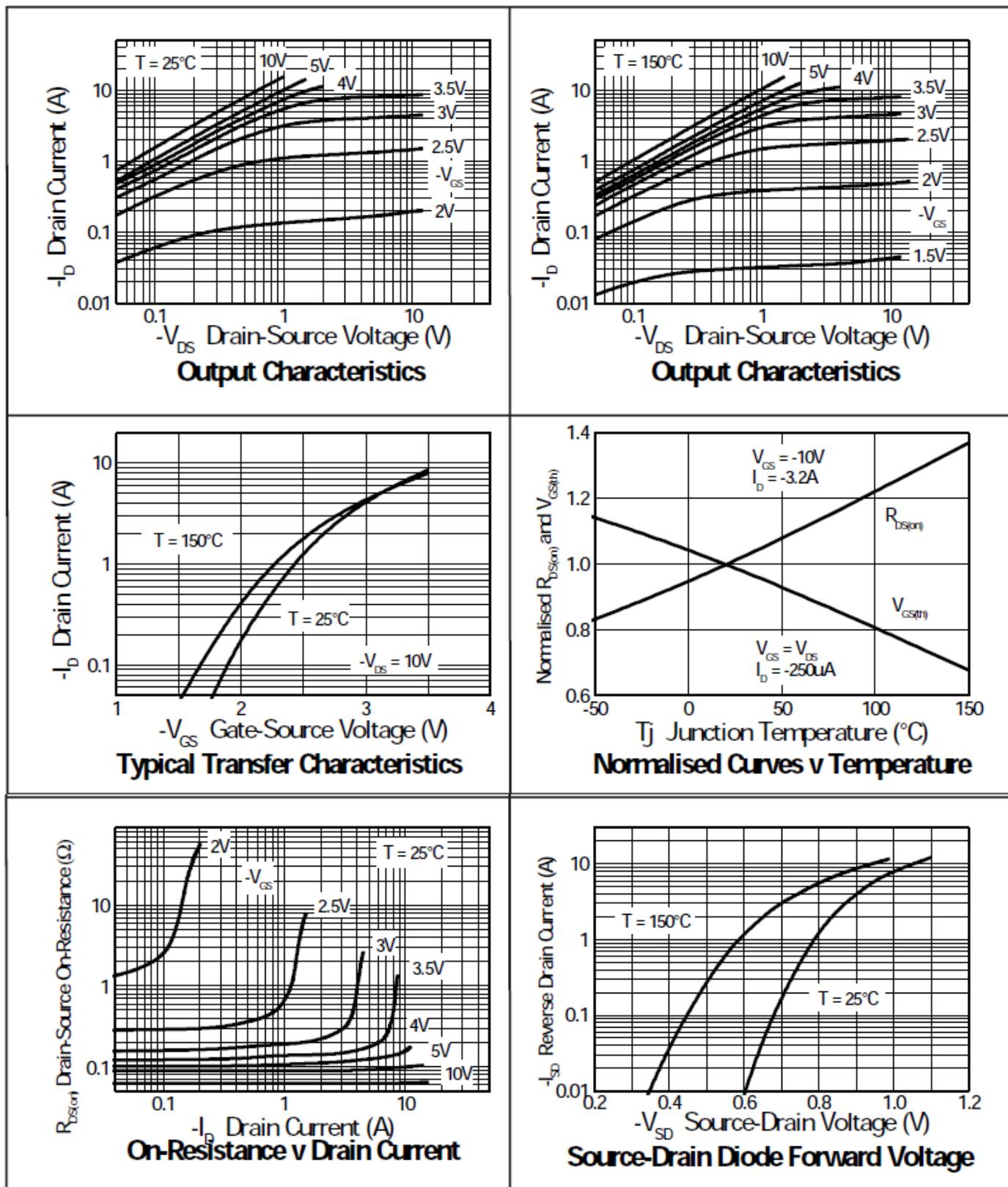
- Notes: 5. For a device surface mounted on 25mm x 25mm FR-4 PCB with high coverage of single sided 1oz copper, in still air conditions.
6. For a device surface mounted on FR-4 PCB measured at t ≤ 5 secs.
7. Repetitive rating 25mm x 25mm FR-4 PCB, D = 0.05, pulse width 10μs - pulse width limited by maximum junction temperature. Refer to Transient Thermal Impedance graph.

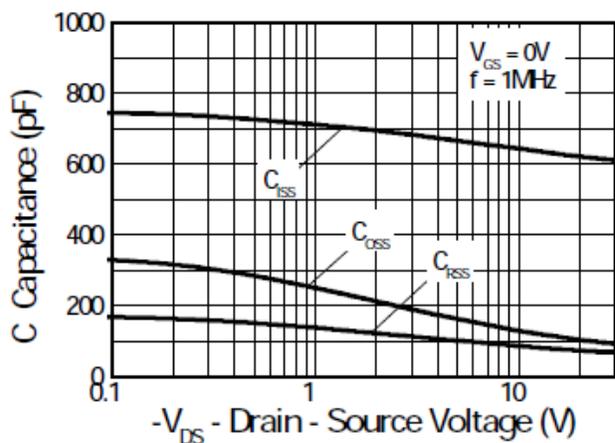
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	-30	-	-	V	I _D = -250μA, V _{GS} = 0V
Zero Gate Voltage Drain Current	I _{DSS}	-	-	-0.5	μA	V _{DS} = -30V, V _{GS} = 0V
Gate-Body Leakage	I _{GSS}	-	-	100	nA	V _{GS} = ±20V, V _{DS} = 0V
Gate-Source Threshold Voltage	V _{GS(TH)}	-1.0	-	-	V	I _D = -250μA, V _{DS} = V _{GS}
Static Drain-Source On-State Resistance (Note 8)	R _{DS(ON)}	-	-	0.070	Ω	V _{GS} = -10V, I _D = -3.2A
				0.110		V _{GS} = -4.5V, I _D = -2.5A
Forward Transconductance (Notes 8 & 10)	g _{fs}	-	6.4	-	S	V _{DS} = -15V, I _D = -3.2A
Diode Forward Voltage (Note 8)	V _{SD}	-	-0.85	-1.2	V	T _J = +25°C, I _S = -2.5A, V _{GS} = 0V
DYNAMIC CHARACTERISTICS						
Input Capacitance (Note 10)	C _{iss}	-	630	-	pF	V _{DS} = -15V, V _{GS} = 0V f = 1MHz
Output Capacitance (Note 10)	C _{oss}	-	113	-	pF	
Reverse Transfer Capacitance (Note 10)	C _{rss}	-	78	-	pF	
Gate Charge (Notes 9 & 10)	Q _g	-	8.28	-	nC	V _{GS} = -5V, V _{DS} = -15V I _D = -3.2A
Total Gate Charge (Notes 9 & 10)	Q _g	-	15.8	-	nC	V _{GS} = -10V, V _{DS} = -15V I _D = -3.2A
Gate-Source Charge (Notes 9 & 10)	Q _{gs}	-	1.84	-	nC	
Gate-Drain Charge (Notes 9 & 10)	Q _{gd}	-	2.8	-	nC	
Turn-On Delay Time (Notes 9 & 10)	t _{D(ON)}	-	1.74	-	ns	V _{DD} = -15V, V _{GS} = -10V I _D = -1A, R _G = 6.0Ω
Turn-On Rise Time (Notes 9 & 10)	t _R	-	2.87	-	ns	
Turn-Off Delay Time (Notes 9 & 10)	t _{D(OFF)}	-	29.2	-	ns	
Turn-Off Fall Time (Notes 9 & 10)	t _F	-	8.72	-	ns	
Reverse Recovery Time (Note 10)	t _{RR}	-	19.5	-	ns	
Reverse Recovery Charge (Note 10)	Q _{RR}	-	16.3	-	nC	T _J = +25°C, I _F = -1.7A, di/dt = 100A/μs

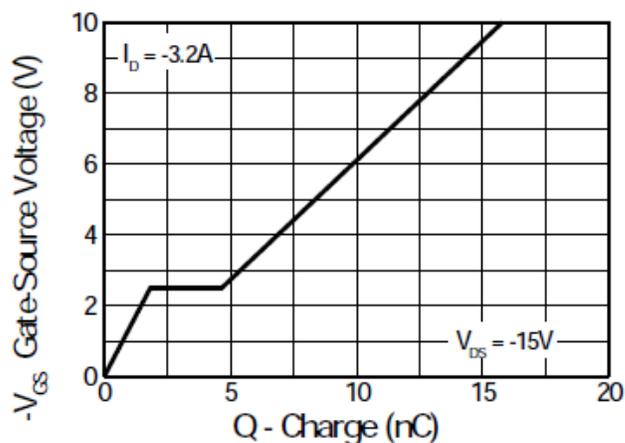
- Notes: 8. Measured under pulsed conditions. Width=300μs. Duty cycle ≤ 2%
9. Switching characteristics are independent of operating junction temperature.
10. For design aid only, not subject to production testing.



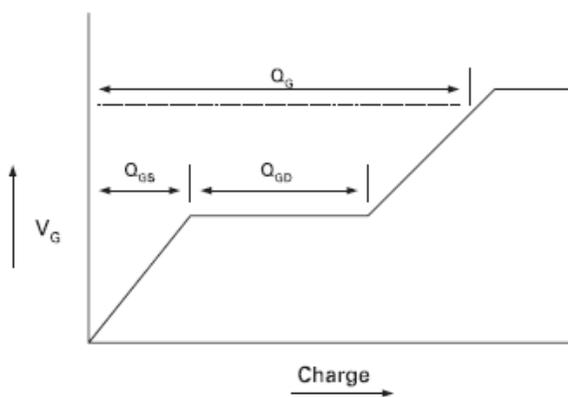




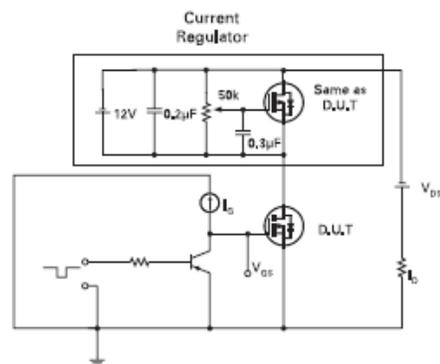
Capacitance v Drain-Source Voltage



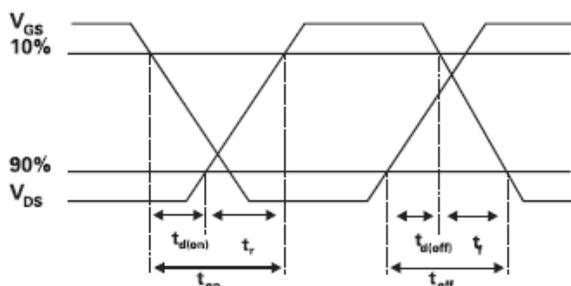
Gate-Source Voltage v Gate Charge



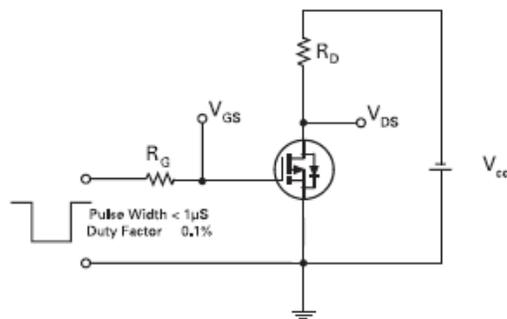
Basic Gate Charge Waveform



Gate Charge Test Circuit

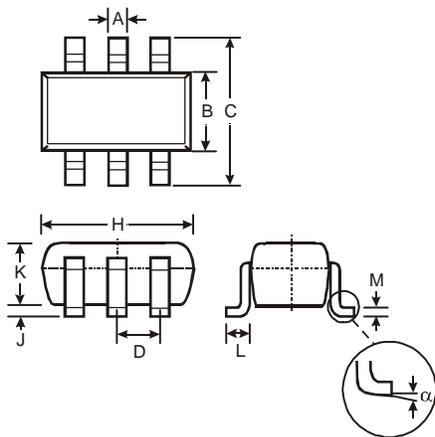


Switching Time Waveforms



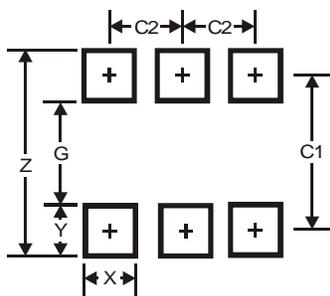
Switching Time Test Circuit

Package Outline Dimensions



SOT26			
Dim	Min	Max	Typ
A	0.35	0.50	0.38
B	1.50	1.70	1.60
C	2.70	3.00	2.80
D	—	—	0.95
H	2.90	3.10	3.00
J	0.013	0.10	0.05
K	1.00	1.30	1.10
L	0.35	0.55	0.40
M	0.10	0.20	0.15
α	0°	8°	—
All Dimensions in mm			

Suggested Pad Layout



Dimensions	Value (in mm)
Z	3.20
G	1.60
X	0.55
Y	0.80
C1	2.40
C2	0.95